10/536798

MODIFIED PTO/SB/08 A & B (06-03)

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## **INTERNATIONAL SEARCH REPORT** REFERENCES

(use as many sheets as necessary)

Sheet	1	of	1

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JC13	ARCTIRTON 27 MAY 2009
Application Number	
Confirmation Number	
Filing Date	May 27, 2005
First Named Inventor	Toru SANO
Art Unit	
Examiner Name	
Attorney Docket Number	er

U.S. PATENT DOCUMENTS					
Examiner Cite	Document Number				
	Number	Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	
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Examiner Cite Initials* No.1	Foreign Patent Document			Publication Date	Name of Patentee or		
	Country Code <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation <sup>6</sup>	
		JР	2001-515216	Α	09-18-2001	Cephedid	
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		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation <sup>6</sup>
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Examiner Signature	Date Considered	

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